JC14 Rec'd PCT/PTO 25 JUL 2005 IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of: Kenji WATANABE et al.

Serial No.: Not yet assigned

(§371 of international application No. PCT/JP2004/000711)

Filed: July 25, 2005

MAPPING-PROJECTION-TYPE ELECTRON BEAM APPARATUS

FOR INSPECTING SAMPLE BY USING ELECTRONS EMITTED

FROM THE SAMPLE

Attorney Docket Number: 052886

Customer Number: 38834

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

Date: July 25, 2005

Sir:

In compliance with 37 C.F.R. §1.56, Applicants direct the attention of the Patent and Trademark Office to the documents listed on the attached PTO/SB/08 and cited in the enclosed international search report. Since the documents were cited in the international search report, it is believed that copies of the documents have been transmitted by the International Bureau.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. 50-2866.

Respectfully submitted,

Westerman, Hattøri, Damiels & Adrian, LLP

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SGA/yap

Enclosure: PTO/SB/08 and International Search Report

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Combined Form PTO/SB/08A&B			Complete if Known			
Announce Form 1 10/30/00A&D				Application Number	New Application 10/543	
INFORMATION DISCLOSURE				Confirmation Number	1	
STATEMENT BY APPLICANT				Filing Date	July 25, 2005 04-18-200	
(use as many sheets as necessary)				First Named Inventor	Kenji WATANABE et al.	
				Art Unit	2881	
				Examiner Name	K. Nguyen	
Sheet	1	of	1	Attorney Docket Number	052886	

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No.1	Document	Number	Publication Date MM-DD-YYYY		
		Number	Kind Code ² (if known)		Name of Patentee or Applicant of Cited Document	
		US				
		US				
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		US				
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	FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	Foreign Patent Document			Publication Date	Name of Patentee or		
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation ⁶	
	T	PCT	WO 99746798		09-16-1999	Hitachi Ltd.		
2002 0002 0000 00		EPO	0 949 653		10-13-1999	Hitachi Instruments Eng. et al.		
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600 HX 901 GD 60	4	PCT	WO 00/72355		11/30/2000	KLA Tencor Corp. et al.		
	All	ave be	en not rec	eived.				

		NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.				
EEE 000 000 EE		"Flectron Energy Discriminator for Wafer Chip Testing", IBM Technical Disclosure Bulletin, Vol. 23,				
] 3	No.6, November 1, 1980, pp.2288-2290.	L			
	6	W. ZHU et al.; "Large Current Density from Carbon Nanotube Field Emitters", Applied Physics Letters, Vol. 75, No. 6, pp.873-875.				
		All have been not received.				

	/Kiet Tuan Nguyen/		08/17/2008
Examiner Signature	7 66 T	Date Considered	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant's unique citation designation number (optional). ²See Kind Codes of USPTO Patent Documents at www.uspto.gov, MPEP 901.04 or in the comment box of this document. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST. 3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to indicate here if English language Translation is attached.